



Industrial AI: Applications in Fault Detection, Diagnosis, and Prognosis

Guest Editors:

Dr. Janet Lin

Department of Civil,
Environmental and Natural
Resources Engineering, Luleå
University of Technology, T2064
Luleå, Sweden

Dr. Liangwei Zhang

Department of Industrial
Engineering, Dongguan
University of Technology,
Dongguan 523808, China

Dr. Haidong Shao

College of Mechanical and
Vehicle Engineering, Hunan
University, Changsha 410082,
China

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Message from the Guest Editors

In the fourth industrial revolution, or Industry 4.0, a key objective is to enhance equipment's ability to perceive its own health state and predict future behavior. The development of artificial intelligence, especially the progress made in deep learning, in the recent decade provides a promising tool in bolstering this enhancement. Such a tool can be a complement or alternative to conventional physics-based and signal-processing-based techniques in fault detection, diagnosis and prognosis applications.

Researchers have started to build data-driven or hybrid models to further boost their prediction accuracy in the above applications, yet there are still some untouched or underexplored territories, such as causal inference, demystifying the black-box modelling, domain adaptation, automatic feature learning, etc. This special issue is to present current innovations and engineering achievements of scientists and industrial practitioners in the area of adopting artificial intelligence techniques in fault detection, diagnosis and prognosis.





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Editor-in-Chief

Prof. Dr. Giulio Nicola Cerullo
Dipartimento di Fisica,
Politecnico di Milano, Piazza L.
da Vinci 32, 20133 Milano, Italy

Message from the Editor-in-Chief

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